Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,023	MAEKAWA ET	AL.
Examiner	Art Unit	
Clark F. Dexter	3724	

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Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	RCH NOTES SEARCH STRATEGY)
	DATE	EXMR
text search	11/13/2007	CFD
text search	8/21/2008	CFD